

<b>Notice of References Cited</b>	Application/Control No. 10/748,729		Applicant(s)/Patent Under Reexamination KIKO, FREDERICK J.	
	Examiner BINH K. TIEU		Art Unit 2614	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,418,221	07-2002	Snow et al.	379/399.01
*	B	US-6,744,883	06-2004	Bingel et al.	379/399.01
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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